RTS RIM Testing Services	Appendix for the BlackBerr SAR Report	y® Smartphone Model	RBW71CW	Page 1(17)
Author Data	Dates of Test	Test Report No	FCC ID:	0CW
Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS -1191-0808-22	L6ARBW7	

APPENDIX D: PROBE & DIPOLE CALIBRATION DATA

RTS M Testing Services	Appendix for the SAR Report	Appendix for the BlackBerry® Smartphone Model RBW71CW SAR Report				
or Data <b>ahriar Ninad</b>	Dates of Test Aug 06-14, Sep 1		Report No <b>S-1191-0808-22</b>	FCC ID: L6ARBW7	OC W	
	_aboratory of	at the factor	IS Schweizerischer	Kalibrierdienst		
Schmid & Pa Engineering Zeughausstrasse		lac MRA	C Service suisse d' Servizio svizzero S Swiss Calibration	di taratura		
The Swiss Accred	wiss Accreditation Service (SAS) litation Service is one of the signatori ment for the recognition of calibratio		Accreditation No.: SCS 108			
Client RIM			Certificato No: ET3-1642_J	an08		
CALIBRA	TION CERTIFICAT	E				
Object	ET3DV6 - SN:1	642				
Calibration proced		cedure for dosimetric E-	field probes			
Calibration date:	January 18, 200	08				
Condition of the ex	librated item In Tolorance					
The measurement	rtificare documents the traceability to na s and the uncertainties with confidence	probability are given on the folk	wing pages and are part of the certi	ficate.		
	ve been conducted in the closed laboration		aure (22 ± 5) G and numbery < 70%	ta.		
Primary Standards Power meter E441 Power sensor E44	9B GB41293874	Cal Date (Calibrated by Co 29-Mar-07 (METAS, Nc. 21 29-Mar-07 (METAS, Nc. 21	7-00670) Mar-08	alibration		
Power sensor E44 Reference 3 dB A Reference 20 dB A Reference 30 dB A Reference Probe I	12A         MY41488087           tternustor         SN: 55054 (3c)           Atternuator         SN: 55086 (20b)           Atternuator         SN: 55129 (30b)           E53D/2         SN: 3013	29-Mar-07 (METAS, No. 21 8-Aug-07 (METAS, No. 213 29-Mar-07 (METAS, No. 21 8-Aug-07 (METAS, No. 21 2-Jan-08 (SPEAG, No. ES)	7-00670) Mar-08 -00719) Aug-08 7-00671) Mar-08 -00720) Aug-08 i-0013_Jan-08 Jan-09			
DAE4	SN: 654	20-Apr-07 (SPEAG, No. DA	E4-654_Apr07) Apr-08 Scheduled C	horiz		
Secondary Stands RF generator HP t Network Analyzer	5648C US3642U01700	Check Date (in house) 4-Aug-99 (SPEAG, in hous 18-Oct-01 (SPEAG, in hous	o chock Oct-07) In house che	ck: Oct-09		
Calibrated by:	Namo Katja Pokovio	Function Technical Var	Signature	life		
Approved by:	Niels Kuster	Quality Manag	ar / /	No.		

RTS RIM Testing Services	Document Appendix for the BlackBerry® Smartphone Model RBW71CW SAR Report				
Author Data	Dates of Test	Test Report No	FCC ID:		
Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS-1191-0808-22	L6ARBW7	0CW	

Calibration Laboratory of Schmid & Partner Engineering AG aughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdie Service suisse d'étalonnage С Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

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dited by the Gwiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agrooment for the recognition of calibration certificates

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Glossary: TSL

Gibbbaary.	
TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
Polarization $\phi$	φ rotation around probe axis
Polarization 8	9 rotation around an axis that is in the plane normal to proce axis (at
	measurement center), i.e., 9 = 0 is normal to probe axis

#### Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

#### Methods Applied and Interpretation of Parameters:

- NORMx, y.z: Assessed for E-field polarization 8 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y z does not effect the E<sup>2</sup>-field uncertainty nside TSI (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z \* irequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx, y, z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Oifset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance recuired.

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Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS -1191-0808-22	L6ARBW7		

January 18, 2008

# Probe ET3DV6

## SN:1642

Manufactured: Last calibrated: Recalibrated: November 7, 2001 January 15, 2007 January 18, 2008

Calibrated for DASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ET3-1642\_Jan08

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Author Data	Dates of Test	Test Report No	FCC ID:	ACTE	
Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	R1S-1191-0808-22	L6ARBW7	OC W	

#### January 18, 2008

### DASY - Parameters of Probe: ET3DV6 SN:1642

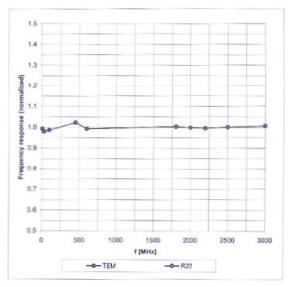
Sensitivity i	in Free Space	a,		Diode	Compression
Norm	X 1.6	7 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP X	91 mV
Norm	Y 1.8	6 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP Y	91 mV
Norm	Z 1.6	4 ± 10.1%	$\mu$ V/(V/m) <sup>2</sup>	DCP Z	94 mV
Sensitivity	in Tissue Sim	nulating Li	quid (Convers	ion Factors	s)
Please see Pa	ge 8.				
Boundary B	Effect				
TSL	900 MHz	Typical S/	AR gradient: 5 % p	er mm	
Senso	r Center to Phanto	om Sulface D	istance	3.7 mm	4.7 mm
SAR	[%] Withou	t Correction /	Vgorithm	11.3	6.7
SARbe	[%] With C	orrection Algo	prithm	0.8	0.4
TSL	1810 MHz	Typical S/	AR gradient: 10 %	per mm	
Senso	r Center to Phante	om Surface D	istance	3.7 mm	4.7 mm
SAR	[%] Withou	t Correction A	Algorithm	14.0	8.3
SAR	[%] With C	orrection Algo	orithm	0.9	0.7
Sensor Off	set				
Probe	Tip to Sensor Cer	nter		2.7 mm	
measuremen	nt multiplied by	the covera	ent is stated as t ge factor k=2, wh of approximately	ich for a nor	uncertainty of mal distribution
corresponds	s to a coverage	problomity	or opproximate.)		
	of NormX,Y,Z do not a zation parameter: unce		uncertainty inside TSL (: red.	see Page 8).	

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Author Data	Dates of Test	Test Report No	FCC ID:	
Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS-1191-0808-22	L6ARBW7	0CW

#### January 18, 2008

#### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: ET3-1642\_Jan08

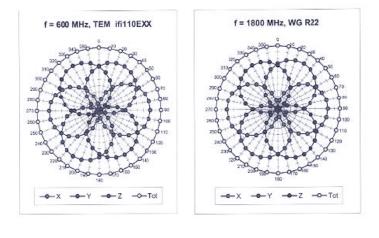
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RTS RIM Testing Services	Document Appendix for the BlackBerry® Smartphone Model RBW71CW SAR Report				
Author Data	Dates of Test	Test Report No	FCC ID:		
Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS-1191-0808-22	L6ARBW7	<b>DCW</b>	

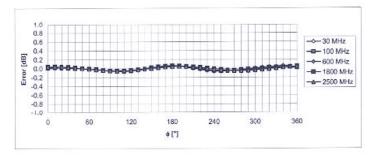
#### ET3DV6 SN:1642

January 18, 2008

. .....



#### Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$



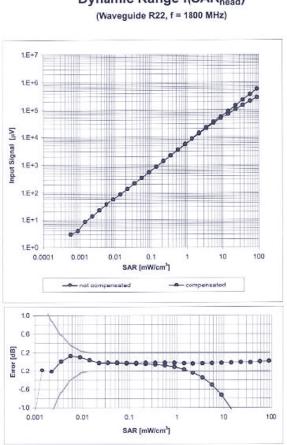
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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RTS RIM Testing Services	Appendix for the BlackBerry® Smartphone Model RBW71CW SAR Report				
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Dynamic Range f(SAR<sub>head</sub>)

Uncertainty of Linearity Assessment: ± 0.6% (k=2)

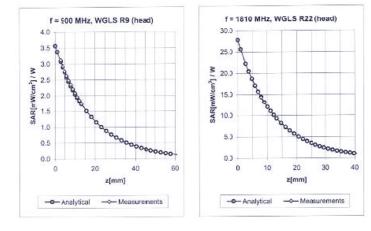
Certificate No: ET3-1642\_Jan08

ET3DV6 SN:1642

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#### **Conversion Factor Assessment**

f [MHz]	Validity [MHz] <sup>c</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.82	1.74	6.42 ± 11.0% (k=2)
1810	+ 50 / + 100	Head	40.0 ± 5%	1.40 ± 5%	0.52	2.85	5.15 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.C ± 5%	1.40 ± 5%	0.57	2.49	4.98 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.76	1.92	4.52 ± 11.8% (k=2)
900	± 50 /± 100	Body	55.C ± 5%	1.05 ± 5%	0.85	1.73	6.13 ± 11.0% (k=2)
1810	1 50 / 1 100	1	53.3±5%	1.52 ± 5%	0.65	2.70	4.85 ± 11.0% (k-2)
1950	± 50 / ± 100	Body	53.2 ± 5%	1.52 ± 5%	0.61	2.32	4.56 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.81	1.88	4.08 ± 11.8% (k=2)

<sup>c</sup> The validity of ±100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency bend.

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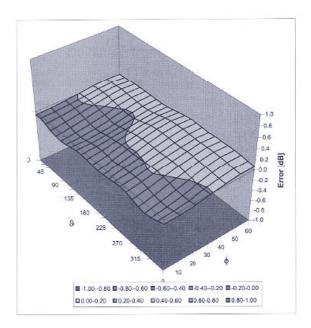
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RTS RIM Testing Services	Appendix for the BlackBerr SAR Report	y® Smartphone Model	RBW71CW	Page 10(17)
Author Data	Dates of Test	Test Report No	FCC ID:	
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#### **Deviation from Isotropy in HSL**

Error (¢, ୬), f = 900 MHz



#### Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k-2)

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a • NT•1	Dates of Test	Test Report No	FCC ID:	
iar Ninad	Aug 06-14, Sep	15-18, 2008   RTS-1191-0808	B-22 L6ARBW7	UC V
Calibration Labo Schmid & Partner Engineering AG Zeughausstrasse 43, 80	r B	ilac-MRA ( C C S	chweizerischer Kalibrierdienst ervice suisse d'étalonnage ervizio svizzero di taratura wiss Calibration Service	
The Swiss Accreditation	Federal Office of Metrology and A n Service is one of the signator for the recognition of calibratio	ies to the EA	SCS 108	
Client RIM	A REAL PROPERTY AND INCOME.		835V2-446_Jan07	81
CALIBRATIO	ON CERTIFICAT	E		
Object	D835V2 - SN: 4	46		
Calibration procedure(s)		edure for dipole validation kits		
Calibration date:	January 8, 2007	ħ		
Condition of the calibrate		tonal standards, which realize the physical units of		
		probability are given on the following pages and an		
All calibrations have bee	n conducted in the closed laborals	ory fability: environment temperature (22 ± 3)°C and	d humidity < 70%.	
Calibration Equipment us	ed (M&TE critical for calibration)			
Primary Standards Power meter EPM-442A	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration	
	GB37480704	03-Oct-06 (METAS, No. 217-00608)	Oct-07	-
Power sensor HP 8481A	U\$37292783	03-Oct-06 (METAS, No. 217-00608)	Oct-07	
Power sensor HP 8481A Reference 20 dB Attenue	stor SN: 5086 (20g)	10-Aug-06 (METAS, No 217-00591)	Oct-07 Aug-07	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua	tor SN: 5085 (20g) tor SN: 5047.2 (10r)	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591)	Aug-07 Aug-07	
Power sensor HP 8481A Reference 20 dB Attenua	tor SN: 5085 (20g) tor SN: 5047.2 (10r)	10-Aug-06 (METAS, No 217-00591)	Aug-07	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua Reference Probe ET3DV DAE4 Secondary Stancards	Ator SN: 5086 (20g) tor SN: 5047.2 (10r) 5 (HF) SN 1507 SN 907 ID #	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house)	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua Reference Probe ET3DV DAE4 Secondary Stancards Power sensor HP 8481A	Ator SN: 5086 (20g) Ator SN: 5047.2 (10r) 5 (HF) SN 1507 SN 907 ID # MY41092317	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house) 18-Oct-02 (SPEAG, in house check Oct-05)	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check In house check: Oct-07	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua Reference Probe ET3DV DAE4 Secondary Stancards	Ator SN: 5086 (20g) Ator SN: 5047.2 (10r) 6 (HP) SN 1507 SN 907 ID # MY41092317 MY41090675	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house)	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check	
Power sensor HP 8481A Reference 20 dB Attenus Reference 10 dB Attenus Reference Probe ET3DV DAE4 Secondary Standards Power sensor HP 8481A RF generator Agilent E44 Network Analyze: HP 875	Ator SN: 5086 (20g) Ator SN: 5047.2 (10r) SN 1507 SN 907 ID # MY41092317 MY4109675 S3E US37390585 S4206 Name	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house) 18-Oct-02 (SPEAG, in house check Oct-05) 11-May-05 (SPEAG, in house check Nov-05) 15-Oct-01 (SPEAG, in house check Oct-06) Function	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check In house check: Oct-07 In house check: Nov-07	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua Reference Probe ET3DV DAE4 Secondary Stancards Power sensor HP 8481A RF generator Agilent E44	Ator SN: 5086 (20g) Ator SN: 5047.2 (10r) 8 (HF) SN 1507 SN 907 ID # MY41092317 MY41092317 MY4100675 S3E US37390585 S4206	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house) 18-Oct-02 (SPEAG, in house check Oct-05) 11-May-05 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Oct-06)	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check In house check: Oct-07 In house check: Nev-07 In house check: Oct-07	
Power sensor HP 8481A Reference 20 dB Attenua Reference 10 dB Attenua Reference Probe ET3DV DAE4 Secondary Standards Power sensor HP 8481A RF generator Agilent E44 Network Analyze: HP 875	Ator SN: 5086 (20g) Ator SN: 5047.2 (10r) SN 1507 SN 907 ID # MY41092317 MY4109675 S3E US37390585 S4206 Name	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house) 18-Oct-02 (SPEAG, in house check Oct-05) 11-May-05 (SPEAG, in house check Nov-05) 15-Oct-01 (SPEAG, in house check Oct-06) Function	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check In house check: Oct-07 In house check: Nov-07 In house check: Oct-07 Signature	
Power sensor HP 8481A Reference 20 dB Attenus Reference 10 dB Attenus Reference Probe ET3DV DAE4 Secondary Standards Power sensor HP 8481A RF generator Agilent E44 Network Analyze: HP 875 Calibrated by: Approved by:	Atar SN: 5086 (20g) Hor SN: 5047.2 (10r) 5 (HF) SN 1507 SN 1507 SN 907 ID # MY41092317 MY41092317 MY41000675 US37390585 S4206 Name Marpal Fehr Katja Pokovic	10-Aug-06 (METAS, No 217-00591) 10-Aug-06 (METAS, No 217-00591) 19-Oct-06 (SPEAG, No. ET3-1507_Oct06) 20-Jul-06 (SPEAG, No. DAE4-907_Jul06) Check Date (in house) 18-Oct-02 (SPEAG, in house check Oct-05) 11-May-05 (SPEAG, in house check No+05) 18-Oct-01 (SPEAG, in house check Oct-06) Function Laboratory Technician	Aug-07 Aug-07 Oct-07 Jul-07 Scheduled Check In house check: Oct-07 In house check: Oct-07 In house check: Oct-07 Signature	

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Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS-1191-0808-22	L6ARBW7	0CW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst

Service suisse d'étalonnage Servizio svizzero di taratura

Swiss Calibration Service

Accreditation No.: SCS 108

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Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

d) DASY4 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the enc of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
  point exactly below the center marking of the flat phantom section, with the arms oriented
  parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
  positioned under the liquid filled phantom. The impedance stated is transformed from the
  measurement at the SMA connector to the feed point. The Return Loss ensures low
  reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- · SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D835V2-445\_Jan07

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Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	RTS-1191-0808-22	L6ARBW7	0CW

#### Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) *C	40.2 ± 6 %	0.88 mho/m ± 6 %
Head TSL temperature during test	(22.2 ± 0.2) °C	-	-

#### SAR result with Head TSL

SAR averaged over 1 cm <sup>3</sup> (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.33 mW / g
SAR normalized	normalized to 1W	9.32 mW / g
SAR for nominal Head TSL parameters 1	normalized to 1W	9.28 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm <sup>3</sup> (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.52 mW / g
SAR normalized	normalized to 1W	g / Win 80.6
SAR for nominal Head TSL parameters <sup>1</sup>	normalized to 1W	6.04 mW/g±16.5% (k=2)

\* Correction to nominal TSL parameters according to d), chapter \*SAR Sensitivities\*

Certificate No: D835V2-446\_Jan07

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#### Appendix

#### Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.8 Ω - 5.8 jΩ	
Return Loss	- 24.7 dB	

#### General Antenna Parameters and Design

Electrical Delay (one direction)	1.386 ns	
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the

feedpoint may be damaged.

#### Additional EUT Data

Manufactured by	SPEAG		
Manufactured on	October 24, 2001		

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Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	K15-1191-0808-22	LOAKBW/	UC W

#### DASY4 Validation Report for Head TSL

Date/Time: 08.01.2007 11:34.46

Test Laboratory: SPEAG, Zurich, Switzerland

#### DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 446

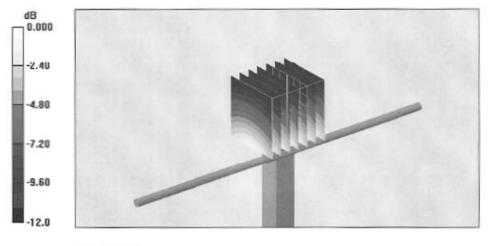
Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium: HSL 900 MHz; Medium parameters used: f = 835 MHz;  $\sigma$  = 0.88 mho/m;  $\epsilon_r$  = 40.3;  $\rho$  = 1000 kg/m<sup>3</sup> Phantom section: Flat Section Measurement Standard: DASY4 (High Precision Assessment)

**DASY4** Configuration:

- Probe: ET3DV6 SN1507 (HF); ConvF(6.09, 6.09, 6.09); Calibrated: 19.10.2006
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn907; Calibrated: 20.07.2006
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; ;
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

#### Pin = 250 mW; d = 15 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.7 V/m; Power Drift = 0.017 dB Peak SAR (extrapolated) = 3.43 W/kg SAR(1 g) = 2.33 mW/g; SAR(10 g) = 1.52 mW/g Maximum value of SAR (measured) = 2.51 mW/g



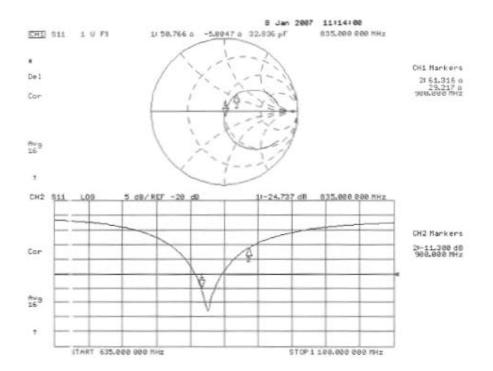
0 dB = 2.51mW/g

Certificate No: D835V2-446\_Jan07

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Impedance Measurement Plot for Head TSL



Certificate No: D835V2-446\_Jan07

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Shahriar Ninad	Aug 06-14, Sep 15-18, 2008	R15-1191-0808-22	L6ARBW7	UC W